Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/711,916	CHEN ET AL.
Examiner	Art Unit

Ryan C. Jager

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SEARCHED						
Class	Subclass	Date	Examiner			
327	536-7	12/20/265	RC2			
363	60	13/21/2005	RCS			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
text search	12/28/2005	pcz		
(see search notes)				
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